

Application No.	Applicant(s)	_
09/781,125	GERLACH ET AL.	
Examiner	Art Unit	
Bornard E Souna	2881	

SEARCHED				
Class	Subclass	Date	Examiner	
250	492.3	6/18/2004	BES	
250	492.2	6/18/2004	BES	
250	492.21	6/18/2004	BES	
250	492.1	6/18/2004	BES	
250	491.1	6/18/2004	BES	
250	396R	6/18/2004	BES	
see	attached			
	:			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
250	492.1-3	6/18/2004	BES		
250	491.1	6/18/2004	BES		
250	396R	6/18/2004	BES		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
((FIB or (focus\$ ion\$ beam\$)) near (array\$ or column\$))	6/18/2004	BES
(seal\$ near (ion adj (gun\$ or source\$)))	6/18/2004	BES
see attached		